

**Search Notes**

Application/Control No.

10/656,223

Examiner

Tamai IE Karl

Applicant(s)/Patent under  
Reexamination

CHOU ET AL.

Art Unit

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	309		
73	504.12		
359	291, 298		
385	18	5/30/2005	KIT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR